

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
VO, KIEM-PHONG

Examiner

TAN TRINH

Art Unit

2684

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0160751 A1	10-2002	Sun et al.	455/412
	B	US-2003/0114140 A1	06-2003	livonen et al.	455/406
	C	US-6,014,693 A	01-2000	Ito et al.	709/219
	D	US-2003/0040276 A1	02-2003	Corn, Steve A.	455/42
	E	US-5,550,966 A	08-1996	Drake et al.	707/104.1
	F	US-2003/0114168 A1	06-2003	Shi et al.	455/456
	G	US-2002/0075869 A1	06-2002	Shah et al.	370/389
	H	US-6,577,595 B1	06-2003	Counterman, Raymond C.	370/230
	I	US-2002/0199102 A1	12-2002	Carman et al.	713/168
	J	US-6,317,165 B1	11-2001	Balram et al.	348/699
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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